Docket No.: 57810-084 **PATENT** 

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of : Customer Number: 20277

Nobuhiko HAYASHI, et al. : Confirmation Number:

Serial No.: Divisional of Appl No. 10/084,050 : Group Art Unit:

Filed: March 10, 2004 : Examiner:

For: NITRIDE-BASED SEMICONDUCTOR ELEMENT AND METHOD OF FORMING

NITRIDE-BASED SEMICONDUCTOR

## **INFORMATION DISCLOSURE STATEMENT**

Mail Stop IDS Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached form PTO-1449. It is respectfully requested that the references be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

The references were cited by or submitted to the U.S. Patent and Trademark Office in parent application Serial No. 10/084,050, filed February 28, 2002, which is relied upon for an

## Serial No.:

earlier filing date under 35 USC 120. Thus, copies of these references are not attached. 37 CFR 1.98(d).

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

MCDERMOTT, WILL & EMERY

Akthur J. Steiner

Registration No. 26,106

600 13<sup>th</sup> Street, N.W. Washington, DC 20005-3096 (202) 756-8000 AJS:gav

Facsimile: (202) 756-8087

Date: March 10, 2004

INFC	ON DISCLOS TON IN AN LICATION	SURE	ATTY. DOCKET N 57810-084	ATTY. DOCKET NO. <b>57810-084</b>		SERIAL NO. Divisional of Appl No. 10/084,050				
			APPLICANT Nobuhiko HAYA	APPLICANT Nobuhiko HAYASHI, et al.						
	O-1449)		FILING DATE March 10, 2004				DUP			
				U.S. PATE	NT DOCUMENTS					
EXAMINER'S	Document Number Publication Date Name of Pat				a Name of Patantas or A	of Patentee or Applicant of Cited Pages, Columns, I			mne Lines Where	
INITIALS	CITE NO.	Num	ber-Kind Code2 (# known)	MM-DD-YYY)	Document Document			Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear		
	<u> </u>	US	6,015,979	1/18/2000	Sugiura e	Sugiura et al.			<u> </u>	
		US	6,051,849	4/18/2000	Davis et	Davis et al.				
		US	6,503,769	01/07/2003	Nakamura	Nakamura et al.				
		US			·. · · · · · · · · · · · · · · · · · ·					
		US								
				FOREIGN P	ATENT DOCUMENTS					
EXAMINER'S INITIALS	Foreign Patent Document CITE Country Codes -Number 4 -Kind NO. Codes (if known)		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	ent	Pages, Columns, Lines Where Relevant Figures Appear	Translation			
			0000 101000	0/40/0000		_		Yes	No	
			2000-164989	6/16/2000				Japan (w/ English Abstract)		
			2000-269144	9/29/2000				Japan (w/ English Abstract)		
		2000-21789		1/21/2000				Japan (w/ English Abstract)		
			10-312971	11/24/1998				Japan (w/ English Abstract)		
					or, Title, Date, Pertinent Page					
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.								
	***************************************	S.	S. Nakamura et al., "Long lifetime violet InGaN/GaN/A1GaN-based semiconductor lasers", Journal of Oyo Denshi Bussei Bunkakai, Vol. 4, (1998), pp. 53-58 and 210-215.							
		Aki	Akira Usui et al., "Thick GaN Epitaxial Growth with Low Dislocation Density by Hydride Vapor Phase Epitaxy", Jpn.  J. Appl. Phys. Vol. 36 (1997), pp. L899-L902.							
		Kev	Kevin Linthicum et al., "Pendeoepitaxy of gallium nitride thin films", Applied Physics Letter, Vol. 75, No. 2, July 12, 1999, pp. 196-198.							
		Isao Kidoguchi et al., "Air-bridged lateral epitaxial overgrowth of GaN thin films", Applied Physics Letter, Vol. 76, No. 25, June 19, 2000, pp. 3768-3770.							. 76, No.	
	AMINER	,		DATE CONSIDERED						

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.